



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

## Product Specification

▶ Domestic Part Number	IRLMS6702
▶ Overseas Part Number	IRLMS6702
▶ Equivalent Part Number	IRLMS6702



EV is the abbreviation of name EVVO

**-20V P-Channel Enhancement Mode MOSFET**
**Description**

The IRLMS6702 uses advanced trench It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

**Application**

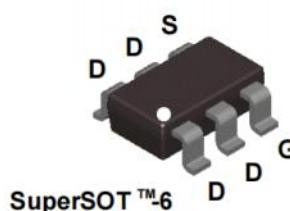
Advanced MOSFET process technology  
Special designed for PWM, load switching and general purpose applications  
Ultra low on-resistance with low gate charge  
Fast switching and reverse body recovery  
150°C operating temperature

**General Features**

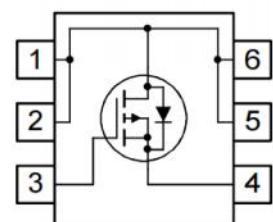
$V_{DS} = -20V, I_D = -6.5A$

$R_{DS(ON)} < 35m\Omega @ V_{GS}=4.5V$

$R_{DS(ON)} < 54m\Omega @ V_{GS}=1.5V$

**SOT23-6L Pin Configuration**


SuperSOT™-6


**Absolute max Rating: @ $T_A=25^\circ C$  unless otherwise specified**

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	-6.5①	A
$I_D @ T_C = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	-4.3 ①	
$I_{DM}$	Pulsed Drain Current ②	-30	
$P_D @ T_C = 25^\circ C$	Power Dissipation ③	1.4	W
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-to-Source Voltage	$\pm 8$	V
$T_J \ T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +150	°C
$R_{\theta JA}$	Junction-to-ambient ( $t \leq 10s$ ) ④	90	°C / W

**-20V P-Channel Enhancement Mode MOSFET**
**Electrical Characterizes @ $T_A=25^\circ C$  unless otherwise specified**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
V(BR)DSS	Drain-to-Source breakdown voltage	$V_{GS} = 0V, I_D = -250\mu A$	-20	—	—	V
$R_{DS(on)}$	Static Drain-to-Source on-resistance	$V_{GS} = -4.5V, I_D = -4A$	—	30	35	$m\Omega$
		$V_{GS} = -1.5V, I_D = -3A$	—	40	54	
		$V_{GS} = -1.8V, I_D = -2A$	—	56	73	
		$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.3	—	-1.0	
VGS(th)	Gate threshold voltage	$T_J = 125^\circ C$	—	-0.44	—	V
		$V_{DS} = -16V, V_{GS} = 0V$	—	—	-1	
IDSS	Drain-to-Source leakage current	$T_J = 125^\circ C$	—	—	-50	$\mu A$
		$V_{DS} = -16V, V_{GS} = 0V$	—	—	10	
IGSS	Gate-to-Source forward leakage	$V_{GS} = -8V$	—	—	-10	$\mu A$
		$V_{GS} = -8V$	—	—	-10	
$Q_g$	Total gate charge	$I_D = -4A, V_{DS} = -10V, V_{GS} = -4.5V$	—	10	—	nC
$Q_{gs}$	Gate-to-Source charge		—	0.77	—	
$Q_{gd}$	Gate-to-Drain("Miller") charge		—	3.5	—	
$t_{d(on)}$	Turn-on delay time	$V_{GS} = -4.5V, V_{DS} = -10V, R_{GEN} = 3\Omega,$	—	10	—	
$t_r$	Rise time		—	8.6	—	ns
$t_{d(off)}$	Turn-Off delay time		—	29	—	
$t_f$	Fall time		—	13	—	
$C_{iss}$	Input capacitance	$V_{GS} = 0V, V_{DS} = -10V, f = 1MHz$	—	939	—	pF
$C_{oss}$	Output capacitance		—	130	—	
$C_{rss}$	Reverse transfer capacitance		—	111	—	

**Source-Drain Ratings and Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
$I_s$	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode.	—	—	-4.2A ①	A
$I_{SM}$	Pulsed Source Current (Body Diode)		—	—	-30	A
$V_{SD}$	Diode Forward Voltage	$I_s = 1A, V_{GS} = 0V$	—	-0.76	-1.0	V
$t_{rr}$	Reverse Recovery Time	$T_J = 25^\circ C, IF = -4A, di/dt = 100A/\mu s$	—	8.7	—	ns
$Q_{rr}$	Reverse Recovery Charge		—	2.3	—	nC

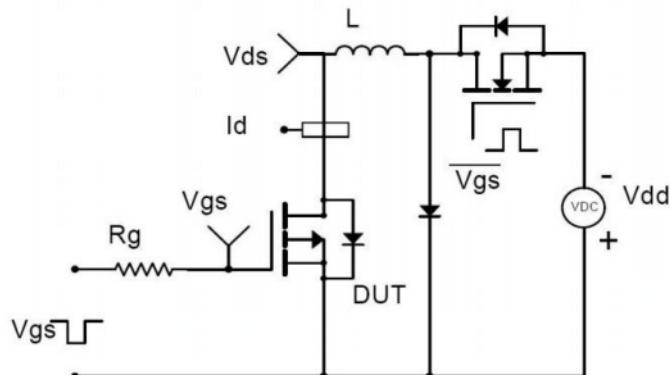
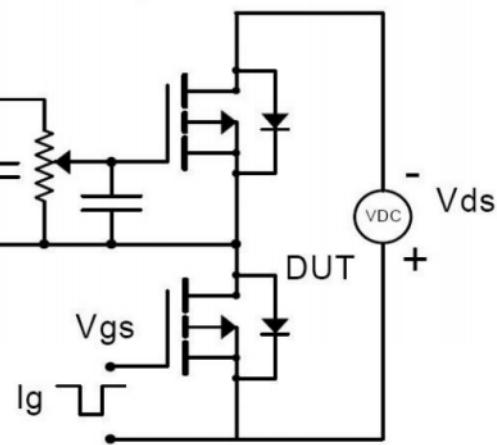
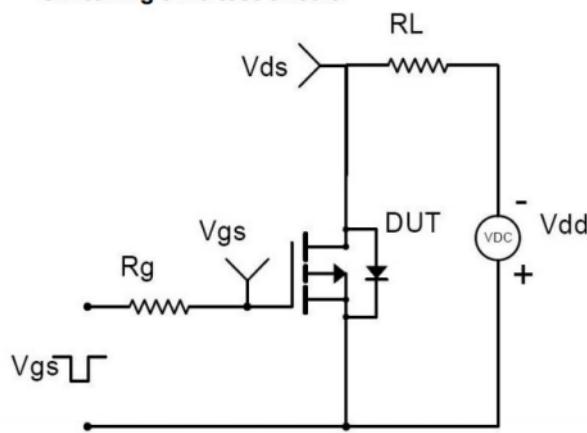
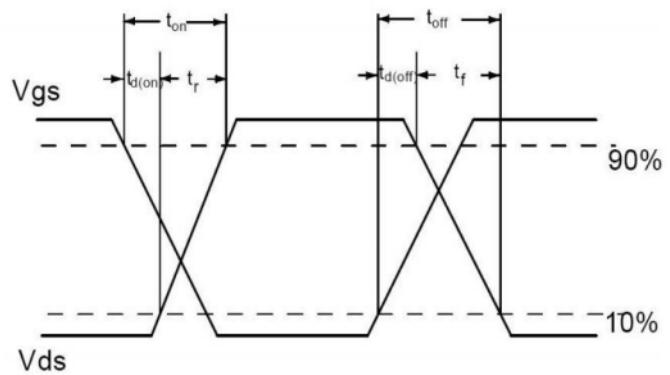
**Notes:**

①Calculated continuous current based on maximum allowable junction temperature.

②Repetitive rating; pulse width limited by max. junction temperature.

③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.

 ④The value of  $R_{θJA}$  is measured with the device mounted on 1 in 2 FR 4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ C$

**-20V P-Channel Enhancement Mode MOSFET**
**Test circuits and Waveforms**
**EAS test circuit:****Gate charge test circuit:****Switching time test circuit:****Switch Waveforms:**

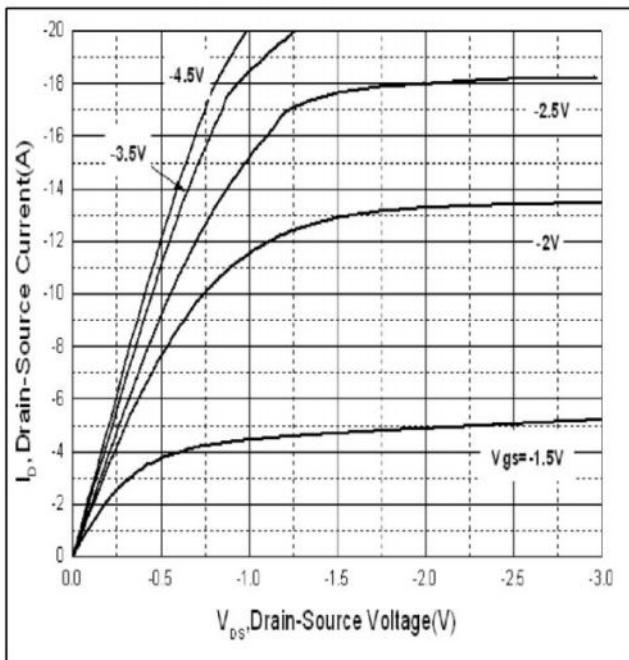
**-20V P-Channel Enhancement Mode MOSFET**
**Typical electrical and thermal characteristics**


Figure 1: Typical Output Characteristics

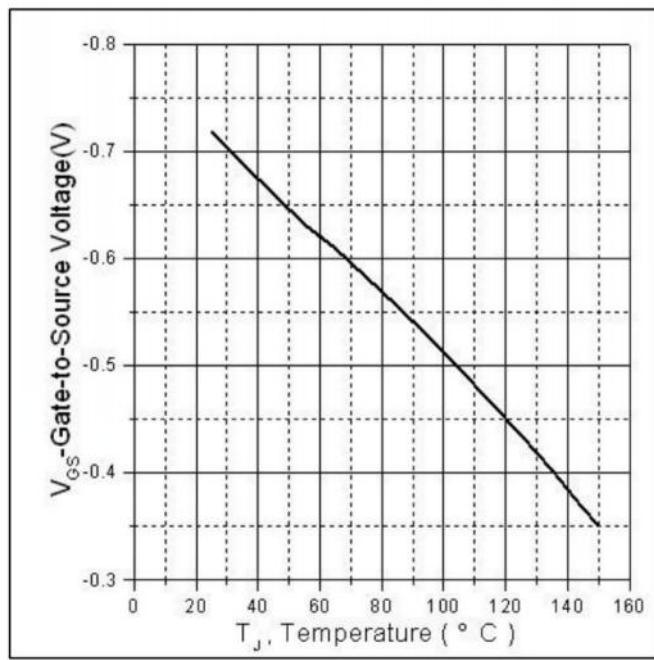


Figure 2. Gate to source cut-off voltage

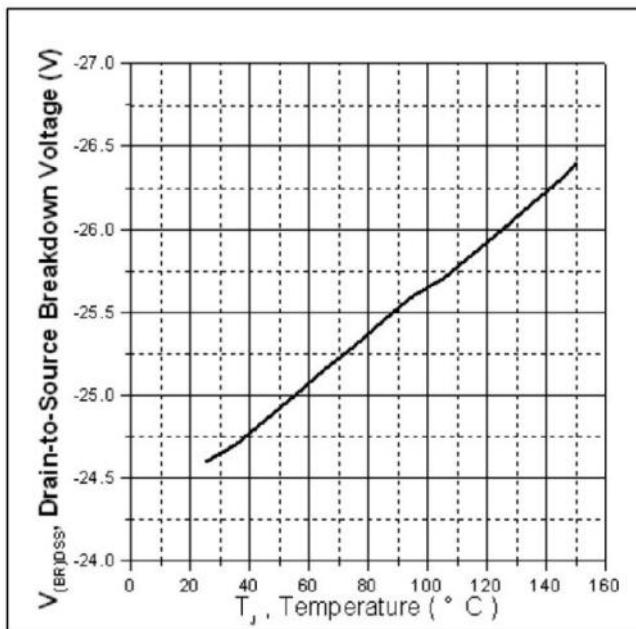


Figure 3. Drain-to-Source Breakdown Voltage Vs.

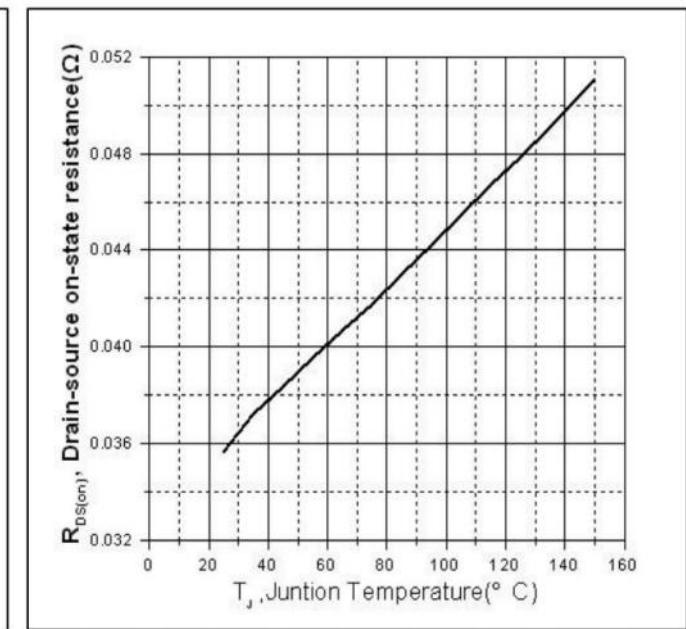
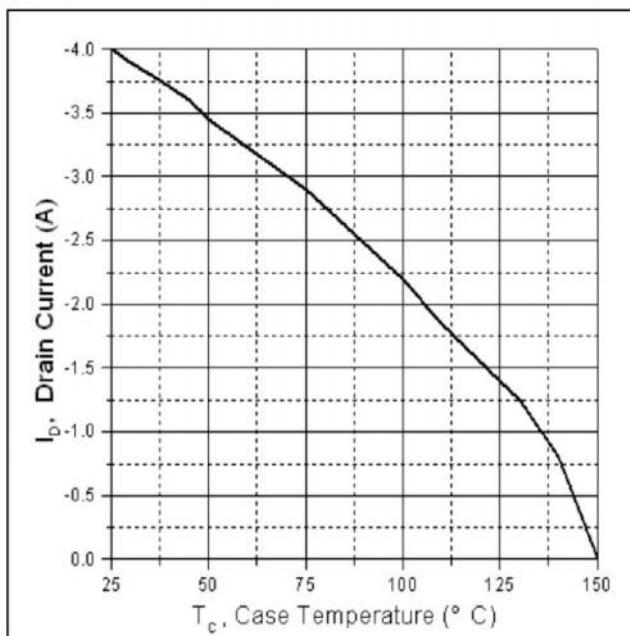


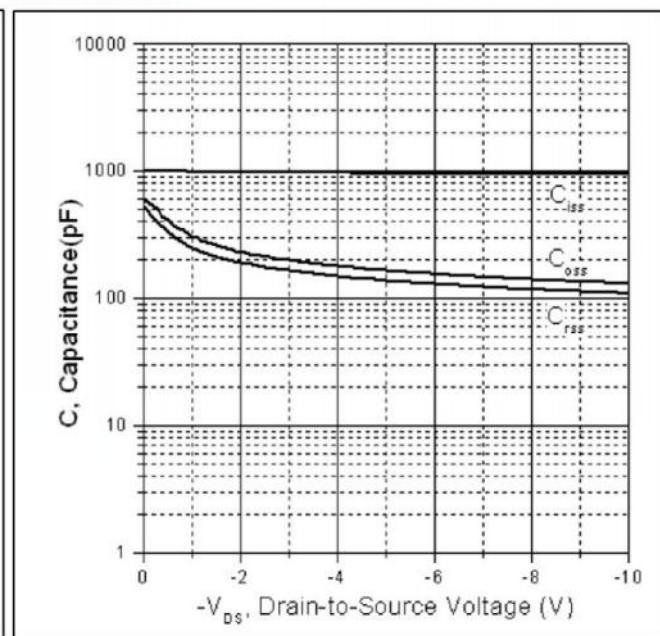
Figure 4: Normalized On-Resistance Vs. Case Temperature

Case Temperature

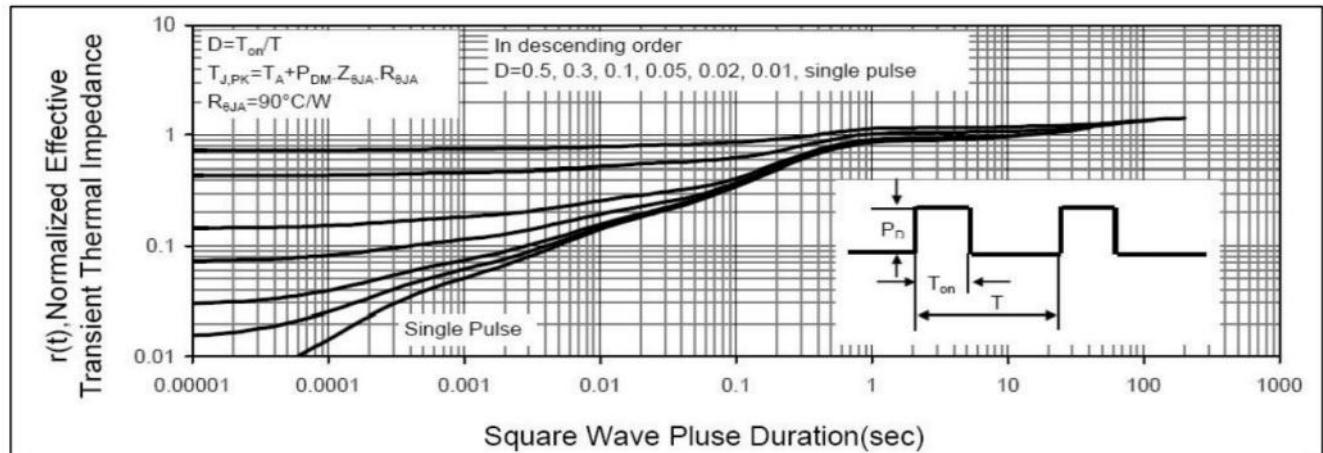
Temperature

**-20V P-Channel Enhancement Mode MOSFET**
**Typical electrical and thermal characteristics**


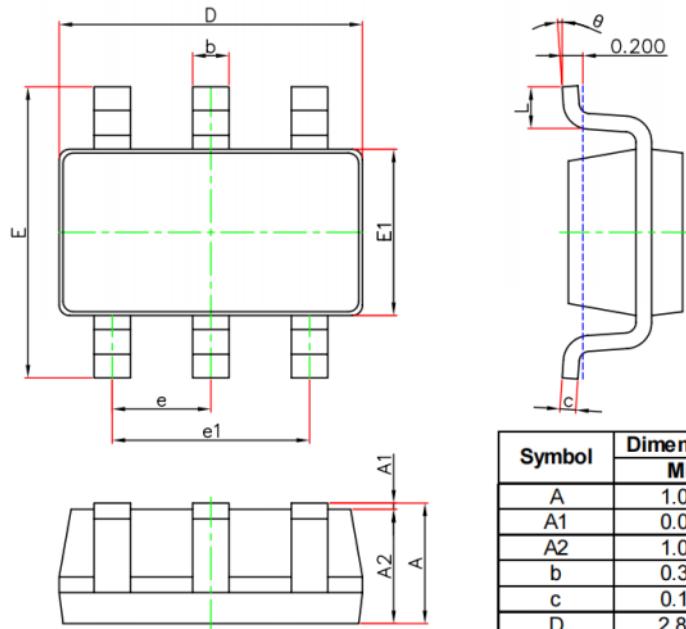
**Figure 5. Maximum Drain Current Vs. Case Temperature**



**Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage**



**Figure 7. Maximum Effective Transient Thermal Impedance Junction-to-Case**

**-20V P-Channel Enhancement Mode MOSFET**
**SOT-23-6L Package Outline Dimensions**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

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